Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/732,315	HAN ET AL.
Examiner	Art Unit
Cheukfan Lee	2625

SEARCHED				
Class	Subclass	Date	Examiner	
358	497	6/30/2006	C.L.	
	442			
	474			
	468			
	445			
	443			
382	312			
	318			
	319			
353	122			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				
	<u> </u>			

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST search: terms include: (scanner same projector same (processor microprocessor CPU)	6/30/2006	C.L.
search terms (cont.): (scanner same (monitor display\$3) same (processor CPU)		
search terms (cont.): directly adj displayed, (stand adj alone)		